



## MICROCIRCUIT DATA SHEET

### MV54ACTQ541-X REV 0A0

Original Creation Date: 02/04/99  
Last Update Date: 05/27/99  
Last Major Revision Date: 02/04/99

## Octal Buffer/Line Driver with TRI-STATE Outputs

### General Description

The ACTQ541 is an octal buffer/line driver designed to be employed as a memory and address driver, clock driver and bus oriented transmitter/receiver.

This device is similar in function to the ACTQ244 while providing flow-through architecture (inputs on opposite side from outputs). This pinout arrangement makes this device especially useful as an output port for microprocessors, allowing ease of layout and greater PC board density.

The ACTQ541 utilizes NSC's FACT TM Quiet Series technology to guarantee quiet output switching the improved dynamic threshold performance. FACT Quiet series features GTO output control and undershoot corrector in addition to split ground bus for superior performance.

### Industry Part Number

54ACTQ541

### NS Part Numbers

54ACTQ541E-QMLV\*  
54ACTQ541J-QMLV\*\*  
54ACTQ541W-QMLV\*\*\*

### Prime Die

D541

### Controlling Document

5962-96829

### Processing

MIL-STD-883, Method 5004

### Quality Conformance Inspection

MIL-STD-883, Method 5005

Subgrp	Description	Temp ( °C)
1	Static tests at	+25 C
2	Static tests at	+125 C
3	Static tests at	-55 C
4	Dynamic tests at	+25 C
5	Dynamic tests at	+125 C
6	Dynamic tests at	-55 C
7	Functional tests at	+25 C
8A	Functional tests at	+125 C
8B	Functional tests at	-55 C
9	Switching tests at	+25 C
10	Switching tests at	+125 C
11	Switching tests at	-55 C

### **Features**

- Guaranteed simultaneous switching noise level and dynamic threshold performance
- Guaranteed pin-to-pin skew AC performance
- Inputs and outputs on opposite sides of package for easy board layout
- Non-inverting TRI-STATE outputs
- Guaranteed 4 kV minimum ESD immunity
- TTL compatible inputs
- Outputs source/sink 24 mA
- Standard Military Drawing (SMD)
  - ACTQ541: 5962-9682901V2A\*, VRA\*\*, VSA\*\*\*

**(Absolute Maximum Ratings)**

(Note 1)

Supply Voltage (Vcc)	-0.5V to +7.0V
DC Input Diode Current (Iik) Vi = -0.5V Vi = Vcc +0.5V	-20 mA +20 mA
DC Input Voltage (Vi)	-0.5V to Vcc +0.5V
DC Output Diode Current (Iok) Vo = -0.5V Vo = Vcc +0.5V	-20 mA +20 mA
DC Output Voltage (Vo)	-0.5V to Vcc +0.5V
DC Output Source or Sink Current (Io)	$\pm$ 50 mA
DC Vcc or Ground Current per Output Pin (Icc or Ignd)	$\pm$ 50 mA
Storage Temperature (Tstg)	-65 C to +150 C
DC Latch-Up Source or Sink Current	$\pm$ 300 mA
Junction Temperature (Tj)	175 C
Thermal Resistance, junction-to-case (jc)	see Mil-Std 1835
Maximum Power Dissipation (pd)	500 mW
Lead Temperature soldering, 10 seconds	+300 C

Note 1: Absolute maximum ratings are those values beyond which damage to the device may occur. The databook specifications should be met, without exception, to ensure that the system design is reliable over its power supply, temperature, and output/input loading variables. National does not recommend operation of FACT TM circuits outside databook specifications.

**Recommended Operating Conditions**

Supply Voltage (Vcc)	4.5V to 5.5V
Input Voltage (Vi)	0V to Vcc
Output Voltage (Vo)	0V to Vcc
Minimum Input Edge Rate Delta V/Delta T ACTQ Devices Vin from 0.8V to 2.0V Vc @ 4.5V, 5.5V	125 mV/ns
Operating Temperature (ta)	-55 C to +125 C
Maximum High Level Output Current (Ioh)	-24 mA
Maximum Low Level Output Current (Iol)	+24 mA

## Electrical Characteristics

### DC PARAMETERS

(The following conditions apply to all the following parameters, unless otherwise specified.)  
 DC: VCC 4.5V to 5.5V, Temp. Range: -55C to 125C.

SYMBOL	PARAMETER	CONDITIONS	NOTES	PIN-NAME	MIN	MAX	UNIT	SUB-GROUPS
IIH	High Level input Current	VCC=5.5V, VIH=5.5V	1, 2	INPUT		0.1	uA	1
			1, 2	INPUT		1.0	uA	2, 3
IIL	Low Level input Current	VCC=5.5V, Vil=0.0V	1, 2	INPUT		-0.1	uA	1
			1, 2	INPUT		-1.0	uA	2, 3
VOL	Low level output voltage	VCC=4.5V, Vil=0.8V, IOL=24.0mA, VIH=2.0V	1, 2	OUTPUT		.36	V	1
			1, 2	OUTPUT		.50	V	2, 3
		VCC=4.5V, Vil=0.8V, IOL=50.0uA, VIH=2.0V	1, 2	OUTPUT		.10	V	1, 2, 3
		VCC=5.5V, Vil=0.8V, IOL=24.0mA, VIH=2.0V	1, 2	OUTPUT		.36	V	1
		VCC=5.5V, Vil=0.8V, IOL=50.0uA, VIH=2.0V	1, 2	OUTPUT		.50	V	2, 3
VIOL	Dynamic Output Current LOW	VCC=5.5V, VIH=5.5V, Vil=0.0V, IOL=50.0mA	1, 2, 5	OUTPUT		1.65	V	1, 2, 3
VOH	High Level Output Voltage	VCC=4.5V, Vil=0.8V, IOH=-24.0mA, VIH=2.0V	1, 2	OUTPUT	3.86		V	1
			1, 2	OUTPUT	3.70		V	2, 3
		VCC=4.5V, Vil=0.8V, IOH=-50.0uA, VIH=2.0V	1, 2	OUTPUT	4.40		V	1, 2, 3
		VCC=5.5V, Vil=0.8V, IOH=-24.0mA, VIH=2.0V	1, 2	OUTPUT	4.86		V	1
			1, 2	OUTPUT	4.70		V	2, 3
VIOH	Dynamic Output Current HIGH	VCC=5.5V, VIH=5.5V, Vil=0.0V, IOH=-50.0mA	1, 2, 5	OUTPUT	5.40		V	1, 2, 3
ICCH	Supply Current	VCC=5.5V, VINH=5.5V, VINL=0.0V	1, 2	VCC		100	nA	1
			1, 2	VCC		80	uA	2, 3
ICCL	Supply Current	VCC=5.5V, VINH=5.5V, VINL=0.0V	1, 2	VCC		100	nA	1
			1, 2	VCC		80	uA	2, 3
ICCZ	Supply Current	VCC=5.5V, VINH=5.5V, VINL=0.0V	1, 2	VCC		100	nA	1
			1, 2	VCC		80	uA	2, 3
ICCF	Supply Current Functional	VCC=5.5V, VINH=5.5V, VINL=0.0V	1, 2	VCC		100	nA	1
			1, 2	VCC		80	uA	2, 3

## Electrical Characteristics

### DC PARAMETERS (Continued)

(The following conditions apply to all the following parameters, unless otherwise specified.)  
 DC: VCC 4.5V to 5.5V, Temp. Range: -55C to 125C.

SYMBOL	PARAMETER	CONDITIONS	NOTES	PIN-NAME	MIN	MAX	UNIT	SUB-GROUPS
ICCT	Supply Current per Input	VCC=5.5V, VIHT=3.4V, VINH=5.5V, VINL=0.0V	1, 2	VCC		1.0	mA	1
			1, 2	VCC		1.6	mA	2, 3
IOZH	Maximum TRI-STATE Leakage Current	VCC=4.5V, VM=4.5V, VIH=2.0V, VINH=4.5V, VINL=0.0V	1, 2	OUTPUT		0.25	uA	1
			1, 2	OUTPUT		5.0	uA	2, 3
		VCC=5.5V, VM=5.5V, VIH=2.0V, VINH=5.5V, VINL=0.0V	1, 2	OUTPUT		0.25	uA	1
			1, 2	OUTPUT		5.0	uA	2, 3
IOZL	Maximum TRI-STATE Leakage Current	VCC=4.5V, VM=0.0V, VIH=2.0V, VINH=4.5V, VINL=0.0V	1, 2	OUTPUT		-0.25	uA	1
			1, 2	OUTPUT		-5.0	uA	2, 3
		VCC=5.5V, VM=0.0V, VIH=2.0V, VINH=5.5V, VINL=0.0V	1, 2	OUTPUT		-0.25	uA	1
			1, 2	OUTPUT		-5.0	uA	2, 3
VIKL	Negative Input Clamp Voltage	VCC=4.5V, IKL=-18mA	1, 2	INPUT		-1.2	V	1, 2, 3
VIKH	Positive Input Clamp Voltage	VCC=4.5V, IKH=18mA	1, 2	INPUT		5.7	V	1, 2, 3
VILD	Maximum Low Level Dynamic Input Voltage	VCC=5.0V, LOAD 50pF / 500 OHMS	6, 9	INPUT		0.8	V	4
VIHD	Minimum High Level Dynamic Input Voltage	VCC=5.0V, LOAD 50pF / 500 OHMS	6, 9	INPUT	2.2		V	4
VOLP	Quiet Output Maximum Dynamic Vol	VCC=5.0V, LOAD 50pF / 500 OHMS	6, 8	OUTPUT		1.5	V	4
VOLV	Quiet Output Minimum Dynamic Vol	VCC=5.0V, LOAD 50pF / 500 OHMS	6, 8	OUTPUT		-1.2	V	4

## Electrical Characteristics

### AC PARAMETERS

(The following conditions apply to all the following parameters, unless otherwise specified.)  
 AC: CL=50pf, RL=500 OHMS, TR & TF=3.0ns, Temp range: -55C to +125C.

SYMBOL	PARAMETER	CONDITIONS	NOTES	PIN-NAME	MIN	MAX	UNIT	SUB-GROUPS
tpLH	Propagation Delay	VCC=4.5V	3, 4, 7	Dn to On	2.0	8.0	ns	9
			3, 4, 7	Dn to On	2.0	9.0	ns	10, 11
tpHL	Propagation Delay	VCC=4.5V	3, 4, 7	Dn to On	2.0	8.0	ns	9
			3, 4, 7	Dn to On	2.0	9.0	ns	10, 11
tpZH	Output Enable Time	VCC=4.5V	3, 4, 7	OE to On	1.5	8.0	ns	9
			3, 4, 7	OE to On	1.5	9.5	ns	10, 11
tpZL	Output Enable Time	VCC=4.5V	3, 4, 7	OE to On	1.5	10.0	ns	9
			3, 4, 7	OE to On	1.5	11.5	ns	10, 11
tpHZ	Output Disable Time	VCC=4.5V	3, 4, 7	OE to On	1.5	8.0	ns	9
			3, 4, 7	OE to On	1.5	9.5	ns	10, 11
tpLZ	Output Disable Time	VCC=4.5V	3, 4, 7	OE to On	1.5	8.0	ns	9
			3, 4, 7	OE to On	1.5	9.5	ns	10, 11

Note 1: SCREEN TESTED 100% ON EACH DEVICE AT +25C & +125C TEMPERATURE, SUBGROUPS 1, 2, 7, & 8.

Note 2: SAMPLE TESTED (METHOD 5005, TABLE 1) ON EACH MFG. LOT AT +25C, +125C & -55C TEMPERATURE, SUBGROUPS A1, 2, 3, 7, & 8.

Note 3: SCREEN TESTED 100% ON EACH DEVICE AT +25C TEMPERATURE ONLY SUBGROUP A9.

Note 4: SAMPLE TESTED (METHOD 5005, TABLE 1) ON EACH MFG. LOT AT +25C, +125C, -55C TEMPERATURE, SUBGROUPS A9, 10 & 11.

Note 5: TRANSMISSION LINE DRIVING TEST, GUARDBANDED LIMITS SET FOR +25C, 2 MSEC DURATION MAX.

Note 6: GUARANTEED BUT NOT TESTED. (DESIGN CHARACTERIZATION DATA)

Note 7: MIN LIMITS GUARANTEED FOR 5.5V BY GUARDBANDING 4.5V MINIMUM LIMITS.

Note 8: MAX NUMBER OF OUTPUTS DEFINED AS (N). DATA INPUTS ARE DRIVEN 0V TO 3V. ONE OUTPUT @ VOL.

Note 9: MAX NUMBER OF DATA INPUTS (N) SWITCHING. (N-1) INPUTS SWITCHING 0V TO 3V. INPUT-UNDER-TEST SWITCHING 3V TO THRESHOLD (VILD), 0V TO THRESHOLD (VIHD), FREQ= 1 MHZ.

**Revision History**

<b>Rev</b>	<b>ECN #</b>	<b>Rel Date</b>	<b>Originator</b>	<b>Changes</b>
0A0	M0003441	05/27/99	Steve Lombard	Initial MDS Release